

<b>Notice of References Cited</b>	Application/Control No. 10/006,466	Applicant(s)/Patent Under Reexamination EKKEL, ERIK	
	Examiner Neveen Abel-Jalil	Art Unit 2165	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0033844	03-2002	Levy et al.	345/744
*	C	US-2002/0049717	04-2002	Routtenberg et al.	707/1
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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